





TEST REPORT No. I21Z70497-EMC01

for

Samsung Electronics Co., Ltd.

Tablet with Bluetooth, WLAN

Model Name: SM-X200

FCC ID: ZCASMX200

with

Hardware Version: REV1.0

Software Version: X200.001

Issued Date: 2021-11-15

Note:

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
I21Z70497-EMC01	Rev.0	1 st edition	2021-11-15

Note: the latest revision of the test report supersedes all previous versions.





CONTENTS

1.	TEST LABORATORY	4
1.1.	. INTRODUCTION & ACCREDITATION	4
1.2.	. TESTING LOCATION	4
1.3.	. TESTING ENVIRONMENT	4
1.4.	PROJECT DATA	4
1.5.	. SIGNATURE	4
2.	CLIENT INFORMATION	5
2.1.	. APPLICANT INFORMATION	5
2.2.	. MANUFACTURER INFORMATION	5
3.	EQUIPMENT UNDER TEST (EUT) AND ANCILLARY EQUIPMENT (AE)	6
3.1.	. ABOUT EUT	6
3.2.	. INTERNAL IDENTIFICATION OF EUT USED DURING THE TEST	6
3.3.	. INTERNAL IDENTIFICATION OF AE USED DURING THE TEST	6
3.4.	. EUT SET-UPS	8
4.		
4.1.	. REFERENCE DOCUMENTS FOR TESTING	9
5.	LABORATORY ENVIRONMENT	10
6.	SUMMARY OF TEST RESULTS	11
7.	TEST EQUIPMENTS UTILIZED	12
INA	NEX A: MEASUREMENT RESULTS	13
INA	NEX B: PERSONS INVOLVED IN THIS TESTING	27





1. Test Laboratory

1.1. Introduction & Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2017 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (ISED#: 24849). The detail accreditation scope can be found on NVLAP website.

1.2. <u>Testing Location</u>

CTTL (BDA)

Address: No. 18A, Kangding Street, Beijing Economic-Technology Development

Area, Beijing, 100176, P.R. China

1.3. <u>Testing Environment</u>

Normal Temperature: 15-35°C Relative Humidity: 20-75%

1.4. Project data

Testing Start Date: 2021-11-03 Testing End Date: 2021-11-15

1.5. Signature

Li Yan

(Prepared this test report)

张新

Zhang Ying

(Reviewed this test report)

900

Zhang Xia

Deputy Director of the laboratory (Approved this test report)





2. Client Information

2.1. Applicant Information

Company Name: Samsung Electronics Co., Ltd.

Address: 19 Chapin Rd., Building D Pine Brook, NJ 07058

City: /
Postal Code: /
Country: /

Contact: Jenni Chun

Email: j1.chun@samsung.com

Telephone: +1-201-937-4203

2.2. Manufacturer Information

Company Name: Samsung Electronics. Co., Ltd.

Samsung R5, Maetan dong 129, Samsung ro

Youngtong gu, Suwon city 443 742, Korea

City: /
Postal Code: /
Country: /

Contact: 조성훈(Sunghoon Cho) Email: ggobi.cho@samsung.com

Telephone: +82-10-2722-4159





3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description Tablet with Bluetooth, WLAN

Model Name SM-X200 FCC ID ZCASMX200

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL, Telecommunication Technology Labs, CAICT.

3.2. Internal Identification of EUT used during the test

EUT ID*	IME/SNI	HW Version	SW Version	Date of receipt
UT09a	2170497UT09a	REV1.0	X200.001	2021.11.03

^{*}EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN	Remarks
AE1	Adapter1	/	/
AE2	Adapter2	/	/
AE3	Adapter3	/	/
AE4	Adapter4	/	/
AE5	Adapter5	/	/
AE6	Adapter6	/	/
AE7	Adapter7	/	/
AE8	Adapter8	/	/
AE9	Adapter9	/	/
AE10	Adapter10	/	/
AE11	Adapter11	/	/
AE12	USB Cable	/	/
AE13	Headset1	/	/
AE14	Headset2	/	/
AE15	Battery1	/	/
AE16	Battery2	/	/
AE17	Battery3	/	/
AE1			
Model		EP-TA50EWE	
Manufacturer		HAEM Co.,Ltd	
Length of cable		/	
AE2			
Model		EP-TA50UWE	
Manufacturer		HAEM Co.,Ltd	





Length of cable AE3 Model **EP-TA50EWE** Manufacturer RFTECH Co., Ltd. Length of cable AE4 EP-TA200EWE Model Manufacturer RFTECH Co., Ltd. Length of cable AE5 EP-TA50EWE Model Manufacturer Salcomp (Shenzhen) Co., Ltd. Length of cable AE6 Model **EP-TA50UWE** Manufacturer Salcomp (Shenzhen) Co., Ltd. Length of cable AE7 Model EP-TA50UWE DONGYANG E&P Inc. Manufacturer Length of cable AE8 EP-TA50BW Model Manufacturer Salcomp (Shenzhen) Co., Ltd. Length of cable AE9 Model EP-TA50JWE Manufacturer **RFTech** Length of cable AE10 EP-TA200JWE Model Manufacturer **RFTech** Length of cable AE11 Model EP-TA50JWE Manufacturer HAEM Length of cable AE12 Model EP-DR140AWE(GH39-01999A) Manufacturer Samsung Electronics Co., Ltd. Length of cable / / AE13 Model CH59-15054A Manufacturer DONGGUAN YOUNGBO ELECTRONICS CO.,LTD





Length of cable /

AE14

Model CH59-15054A

Manufacturer CRESYN HANOI Co., Ltd

Length of cable /

AE15

Type Secondary Li-ion Battery

SN HQ-6300NA

Manufacturer Ningde Amperex Technology Limited

AE16

Type Secondary Li-ion Battery

SN HQ-6300SD

Manufacturer SCUD (Fujian) Electronics CO.,LTD

AE17

Type Secondary Li-ion Battery

SN HQ-6300SA

Manufacturer SCUD (Fujian) Electronics CO.,LTD

Note: The USB cables are shielded.

3.4. General Description

Equipment under Test (EUT) is a model of Tablet with Bluetooth, WLAN with integrated an tenna

Samples undergoing test were selected by the client.

The detail information about EUT please refers to manual and specifications provide by manufacturer.

3.5. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.1	UT09a + AE1 + AE12	Charger1+ R Camera
Set.2	UT09a + AE2 + AE12+ AE13	Charger2+ MP4+ Headset1
Set.3	UT09a + AE3 + AE12+ AE14	Charger3+ F camera+Headset2
Set.4	UT09a + AE4 + AE12+ AE13	Charger4+MP3+ Headset1
Set.5	UT09a + AE5 + AE12+ AE14	Charger5+MP4+ Headset2
Set.6	UT09a + AE6	Charger6
Set.7	UT09a + AE7	Charger7
Set.8	UT09a + AE8	Charger8
Set.9	UT09a + AE9+ AE13	Charger9+R Camera +Headset1
Set.10	UT09a + AE10+ AE14	Charger10+ MP4+ Headset2
Set.11	UT09a + AE11	Charger11+ F camera
Set.12	UT09a + AE12 + AE13	USB SD TO PC + Headset1
Set.13	UT09a + AE12 + AE14	USB PC TO SD + Headset2

Note: All the set-ups above were tested but only the worst test data of worst set-up showed in this report.





4. Reference Documents

4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 15, Subpart B	Radio frequency devices - Unintentional Radiators	2019
ANSI C63.4	American National Standard for	2014
	Methods of Measurement of Radio-	
	Noise Emissions from Low-Voltage	
	Electrical and Electronic Equipment	
	in the Range of 9 kHz to 40 GHz	

Note: The test methods have no deviation with standards.





5. LABORATORY ENVIRONMENT

Semi-anechoic chamber SAC-2 (10 meters × 6.7 meters × 6.1 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 15 %, Max. = 75 %
Chickling offoctiveness	0.014MHz - 1MHz, >60dB;
Shielding effectiveness	1MHz - 1000MHz, >90dB.
Electrical insulation	> 2 MΩ
Ground system resistance	< 4 Ω
Normalised site attenuation (NSA)	< ± 4 dB, 3m distance, from 30 to 1000 MHz
Site voltage standing-wave ratio (S_{VSWR})	Between 0 and 6 dB, from 1GHz to 18GHz
Uniformity of field strength	Between 0 and 6 dB, from 80 to 6000 MHz

Shielded room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB;
	1MHz-1000MHz, >90dB.
Electrical insulation	> 2 MΩ
Ground system resistance	< 4 Ω





6. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:		
Р		Pass
Variation Caluman	NA	Not applicable
Verdict Column	F	Fail
	BR	Re-use test data from basic model report.

Items	Test Name	Clause in FCC rules	Section in this report	Verdict	Test Location
1	Radiated Emission	15.109(a)	A.1	Р	CTTL(BDA)
2	Conducted Emission	15.107(a)	A.2	Р	CTTL(BDA)





7. Test Equipments Utilized

			SERIES		CAL DUE	CALIBRATI
NO.	Description	TYPE	NUMBER	MANUFACTURE	DATE	ON
			NUMBER			INTERVAL
1	Test Receiver	ESU26	100376	R&S	2022-09-15	1 year
2	Test Receiver	ESCI	100766	R&S	2022-03-09	1 year
3	LISN	ENV216	101459	R&S	2022-03-09	1 year
4	BiLog Antenna	VULB9163	9163-514	Schwarzbeck	2022-03-22	1 year
5	EMI Antenna	3117	00119024	ETS-Lindgren	2022-04-11	1 year
	Universal Radio					
6	Communication	CMW500	167943	R&S	2022-04-05	1 year
	Tester					
7	Printer	P1606dn	VNC3L52122	HP	N/A	N/A
8	Keyboard	KU-1601	2048361	Lenovo	N/A	N/A
9	Mouse	EMS-537A	8021S3MC	Lenovo	N/A	N/A
10	PC	M4000e-17	M706RMW2	Lenovo	N/A	N/A





ANNEX A: MEASUREMENT RESULTS

A.1 Radiated Emission

Reference

FCC: CFR Part 15.109(a).

A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator (USB mode of MS and charging mode of MS) at distances of 3 meters(for 30MHz-1GHz) and 3 meters (for above 1GHz) is tested. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 8.3. The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

A.1.2 EUT Operating Mode

The MS is operating in the USB mode, charging mode, MP4, MP3, CAMERA and SD mode. All equipment is placed on the test table top and arranged in a typical configuration in accordance with ANSI C63.4-2014 and manipulated to obtain worst case emissions.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.1.3 Measurement Limit

Frequency range	Field strength limit (μV/m)			
(MHz)	Quasi-peak	Average	Peak	
30-88	100			
88-216	150			
216-960	200			
960-1000	500			
>1000		500	5000	

Note: the above limit is for 3 meters test distance. 10 meters' limit is got by converting.

A.1.4 Test Condition

Frequency range (MHz)	RBW/VBW	Sweep Time (s)	Detector
30-1000	120kHz (IF Bandwidth)	5	Peak/Quasi-peak
Above 1000	1MHz/3MHz	15	Peak, Average





A.1.5 Measurement Results

A "reference path loss" is established and the A_{Rpl} is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

Result = $P_{Mea} + A_{Rpl} = P_{Mea} + G_A + G_{PL}$

Where

G_A: Antenna factor of receive antenna

G_{PL}: Path Loss

P_{Mea}: Measurement result on receiver.

Measurement uncertainty (worst case): 30MHz-1GHz: 5.40dB, 1GHz-18GHz: 4.32dB, *k*=2.

Note: all the set-up lists in section 3.5 were tested and only the worst test data of worst set-up showed in this section.

Measurement results for Set.2:

Adapter2+ MP4+ Headset1 /Average detector

Frequency	Measurement	Cable	Antenna	Receiver	Limit	Margin	Antenna
(MHz)	Result	loss	Factor	Reading		· ·	Pol.
(IVITIZ)	(dBµV/m)	(dB)	(dB/m)	(dBμV)	(dBμV/m)	(dB)	(H/V)
17586.500	42.93	-16.9	40.6	19.18	54.0	11.1	V
17601.500	42.89	-16.6	40.6	18.85	54.0	11.1	V
17595.500	42.85	-16.7	40.6	18.88	54.0	11.2	V
17593.500	42.83	-16.7	40.6	18.91	54.0	11.2	V
17598.500	42.80	-16.6	40.6	18.76	54.0	11.2	Н
17601.000	42.80	-16.6	40.6	18.74	54.0	11.2	V

Adapter2+ MP4+ Headset1 /Peak detector

Frequency (MHz)	Measurement Result (dBµV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBµV)	Limit (dBµV/m)	Margin (dB)	Antenna Pol.
		(ub)					(H/V)
17594.000	55.1	-16.7	40.6	31.21	74.0	18.9	V
17018.500	54.8	-18.1	41.2	31.68	74.0	19.2	V
17580.500	54.7	-17.0	40.6	31.14	74.0	19.3	V
16983.500	54.7	-18.0	41.2	31.49	74.0	19.3	V
17020.500	54.6	-18.1	41.2	31.55	74.0	19.4	Н
17596.500	54.5	-16.6	40.6	30.51	74.0	19.5	V





Measurement results for Set.3:

Adapter3+ Headset2+ Front camera /Average detector

Frequency	Measurement	Cable	Antenna	Receiver	Limit	Margin	Antenna
(MHz)	Result	loss	Factor	Reading	eading (dBμV/m) (dB)		Pol.
(IVITIZ)	(dBµV/m)	(dB)	(dB/m)	(dBµV)	(ασμν/ιιι)	(ub)	(H/V)
17595.000	42.94	-16.7	40.6	18.98	54.0	11.1	Н
17594.000	42.91	-16.7	40.6	18.97	54.0	11.1	V
17593.000	42.87	-16.7	40.6	18.97	54.0	11.1	V
17592.000	42.85	-16.7	40.6	18.96	54.0	11.2	V
17596.000	42.82	-16.6	40.6	18.84	54.0	11.2	V
17591.000	42.82	-16.8	40.6	18.96	54.0	11.2	Н

Adapter3+ Headset2+ Front camera /Peak detector

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Limit (dBµV/m)	Margin (dB)	Antenna Pol. (H/V)
17491.500	55.5	-17.6	40.7	32.32	74.0	18.5	Н
17371.000	54.9	-17.4	40.8	31.55	74.0	19.1	Н
17425.500	54.8	-17.6	40.8	31.62	74.0	19.2	V
17588.500	54.7	-16.8	40.6	30.89	74.0	19.3	Н
17596.500	54.7	-16.6	40.6	30.68	74.0	19.3	Н
17513.500	54.6	-17.6	40.7	31.51	74.0	19.4	V





Measurement results for Set.12:

USB (SD) mode+ Headset1 /Average detector

Frequency	Measurement	Cable	Antenna	Receiver	Limit	Margin	Antenna
(MHz)	Result	loss	Factor	Reading	(dBµV/m)	(dB)	Pol.
(171112)	(dBµV/m)	(dB)	(dB/m)	(dBµV)	(αδμν/π)	(ub)	(H/V)
17594.500	42.35	-16.7	40.6	18.41	54.0	11.6	V
17600.500	42.27	-16.5	40.6	18.20	54.0	11.7	V
17591.000	42.23	-16.8	40.6	18.37	54.0	11.8	Н
17598.000	42.20	-16.6	40.6	18.17	54.0	11.8	V
17601.000	42.19	-16.6	40.6	18.14	54.0	11.8	V
17593.500	42.18	-16.7	40.6	18.26	54.0	11.8	V

USB (SD) mode+ Headset1 /Peak detector

Frequency	Measurement	Cable	Antenna	Receiver	Limit	Margin	Antenna
(MHz)	Result	loss	Factor	Reading	(dBµV/m)	(dB)	Pol.
(IVIIIZ)	(dBµV/m)	(dB)	(dB/m)	(dBμV)	(ασμν/π)	(ub)	(H/V)
17597.000	54.9	-16.6	40.6	30.90	74.0	19.1	V
17637.500	54.8	-17.4	40.6	31.56	74.0	19.2	V
17576.500	54.7	-17.1	40.6	31.21	74.0	19.3	Н
17568.000	54.4	-17.4	40.6	31.15	74.0	19.6	Н
16382.500	54.4	-18.1	41.1	31.42	74.0	19.6	V
17481.000	54.3	-17.7	40.7	31.24	74.0	19.7	V





Adapter2+ MP4+ Headset1, Set.2

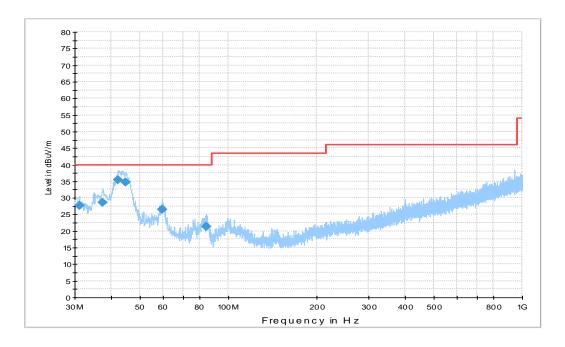


Figure A.1 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Height	Polarization	Azimuth	Corr.	Margin	Limit
(MHz)	(dBµV/m)	(cm)		(deg)	(dB)	(dB)	(dBµV/m)
31.164000	27.7	100.0	V	255.0	-1.1	12.3	40.0
37.372000	28.6	100.0	V	300.0	-0.2	11.4	40.0
42.125000	35.4	100.0	V	105.0	0.2	4.6	40.0
44.841000	34.8	113.0	V	90.0	0.1	5.2	40.0
59.391000	26.6	112.0	V	0.0	-0.4	13.4	40.0
84.320000	21.4	113.0	V	315.0	-4.6	18.6	40.0





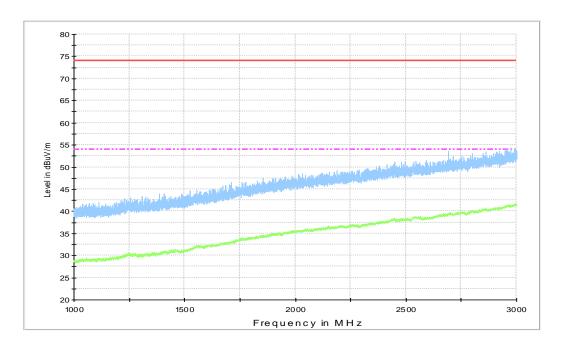


Figure A.2 Radiated Emission from 1GHz to 3GHz

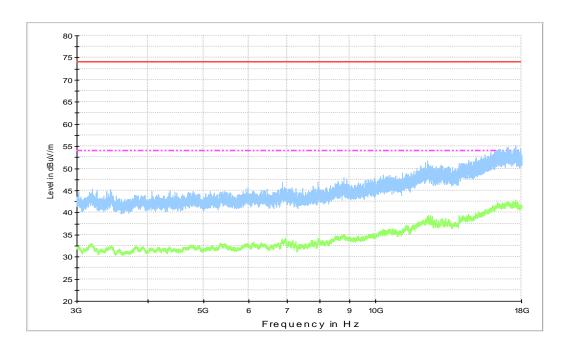


Figure A.3 Radiated Emission from 3GHz to 18GHz





Adapter3+ Headset2+ Front camera, Set.3

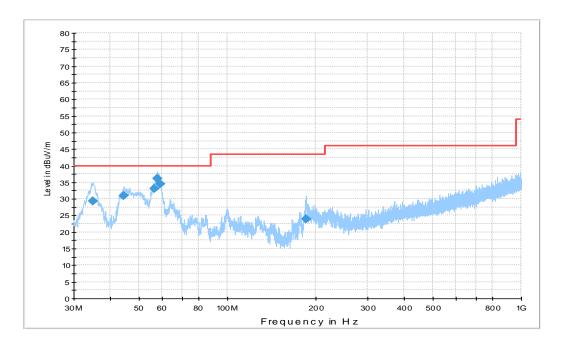


Figure A.4 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Height	Polarization	Azimuth	Corr.	Margin	Limit
(MHz)	(dBµV/m)	(cm)		(deg)	(dB)	(dB)	(dBµV/m)
34.850000	29.3	100.0	V	165.0	-0.6	10.7	40.0
44.453000	30.9	113.0	V	75.0	0.1	9.1	40.0
56.384000	33.0	100.0	V	225.0	-0.3	7.0	40.0
57.839000	36.2	100.0	V	225.0	-0.3	3.8	40.0
59.197000	34.4	100.0	V	225.0	-0.4	5.6	40.0
185.39400	24.0	112.0	V	0.0	-2.2	19.5	43.5





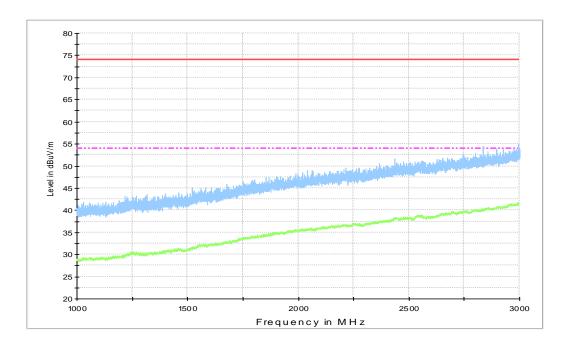


Figure A.5 Radiated Emission from 1GHz to 3GHz

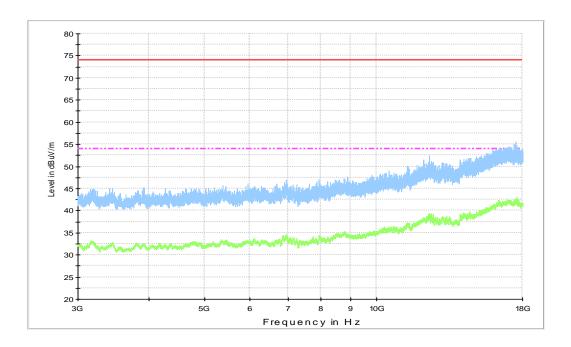


Figure A.6 Radiated Emission from 3GHz to 18GHz





USB (SD) mode+ Headset1+RX LTE B17, Set.12

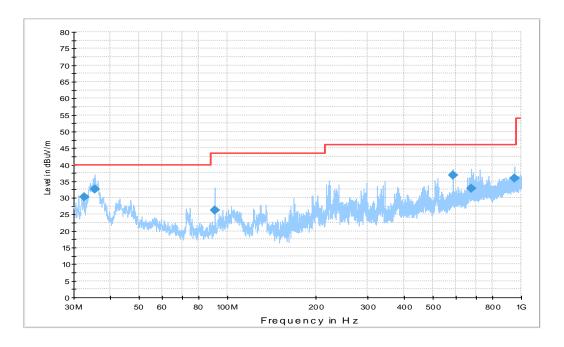


Figure A.7 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Height	Polarization	Azimuth	Corr.	Margin	Limit
(MHz)	(dBµV/m)	(cm)		(deg)	(dB)	(dB)	(dBµV/m)
32.619000	30.2	100.0	V	285.0	-0.9	9.8	40.0
35.335000	32.6	113.0	V	239.0	-0.5	7.4	40.0
90.625000	26.4	125.0	Н	285.0	-2.7	17.1	43.5
585.03400	36.8	100.0	Н	45.0	7.9	9.2	46.0
676.40800	33.0	100.0	V	15.0	8.9	13.0	46.0
949.36600	35.9	113.0	Н	75.0	12.5	10.1	46.0





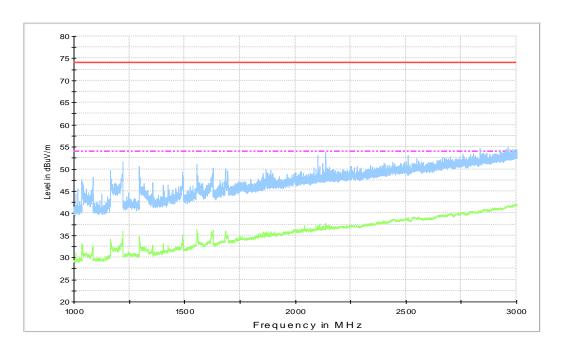


Figure A.8 Radiated Emission from 1GHz to 3GHz

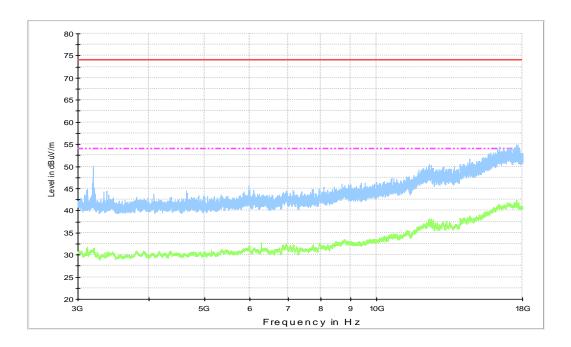


Figure A.9 Radiated Emission from 3GHz to 18GHz





A.2 Conducted Emission

Reference

FCC: CFR Part 15.107(a).

A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 7.3.

A.2.2 EUT Operating Mode

The MS is operating in the USB mode, charging mode, MP4, CAMERA and SD mode.

The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBµV)				
	Quasi-peak	Average			
0.15-0.5	66 to 56*	56 to 46*			
0.5-5	56	46			
5-30 60 50					
*Decreases with the logarithm of the frequency					

A.2.4 Test Condition in charging mode

Voltage (V)	Frequency (Hz)
120	60

RBW/IF bandwidth	Sweep Time(s)
9kHz	1





A.2.5 Measurement Results

Measurement uncertainty: U= 3.10 dB, k=2.

Note: all the set-up lists in section 3.5 were tested and only the worst test data of worst set-up showed in this section.

Set.3

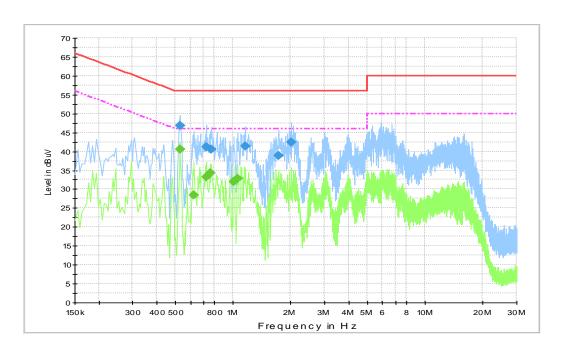


Figure A.10 Conducted Emission

Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

Final Result 1

Frequency	QuasiPeak	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.528000	46.8	5000.0	9.000	On	L1	19.8	9.2	56.0
0.726000	41.2	5000.0	9.000	On	L1	19.8	14.8	56.0
0.775500	40.5	5000.0	9.000	On	N	19.8	15.5	56.0
1.158000	41.5	5000.0	9.000	On	L1	19.7	14.5	56.0
1.734000	38.9	5000.0	9.000	On	N	19.7	17.1	56.0
2.008500	42.5	5000.0	9.000	On	L1	19.7	13.5	56.0

Frequency	Average	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.528000	40.5	5000.0	9.000	On	L1	19.8	5.5	46.0
0.627000	28.4	5000.0	9.000	On	N	19.8	17.6	46.0
0.726000	33.2	5000.0	9.000	On	L1	19.8	12.8	46.0
0.766500	34.3	5000.0	9.000	On	L1	19.8	11.7	46.0
1.009500	31.9	5000.0	9.000	On	L1	19.7	14.1	46.0
1.059000	32.8	5000.0	9.000	On	L1	19.7	13.2	46.0





Set.10

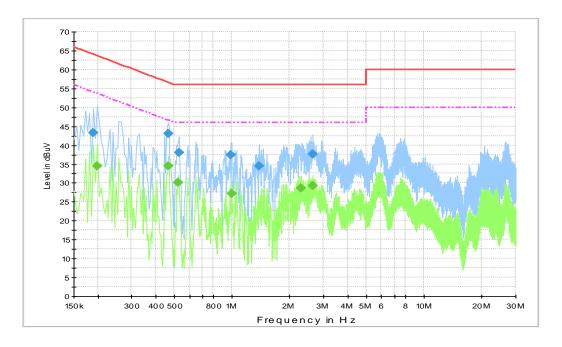


Figure A.11 Conducted Emission

Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

Final Result 1

Frequency	QuasiPeak	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.190500	43.2	5000.0	9.000	On	L1	20.0	20.8	64.0
0.465000	43.0	5000.0	9.000	On	L1	19.9	13.6	56.6
0.528000	38.1	5000.0	9.000	On	L1	19.8	17.9	56.0
0.987000	37.4	5000.0	9.000	On	L1	19.7	18.6	56.0
1.383000	34.6	5000.0	9.000	On	L1	19.7	21.4	56.0
2.634000	37.7	5000.0	9.000	On	L1	19.6	18.3	56.0

Frequency	Average	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.199500	34.6	5000.0	9.000	On	L1	19.9	19.1	53.6
0.465000	34.5	5000.0	9.000	On	L1	19.9	12.1	46.6
0.523500	30.2	5000.0	9.000	On	L1	19.9	15.8	46.0
0.996000	27.1	5000.0	9.000	On	L1	19.7	18.9	46.0
2.292000	28.6	5000.0	9.000	On	L1	19.6	17.4	46.0
2.634000	29.2	5000.0	9.000	On	L1	19.6	16.8	46.0





USB (SD) mode, Set.12

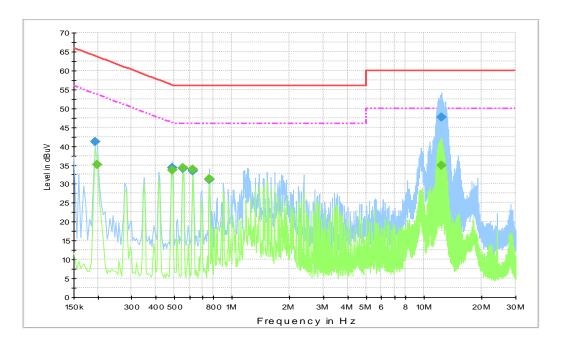


Figure A.12 Conducted Emission

Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

Final Result 1

Frequency	QuasiPeak	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.195000	41.2	5000.0	9.000	On	L1	19.9	22.7	63.8
0.487500	34.3	5000.0	9.000	On	L1	19.9	21.9	56.2
0.555000	34.0	5000.0	9.000	On	L1	19.9	22.0	56.0
0.627000	33.5	5000.0	9.000	On	L1	19.8	22.5	56.0
0.762000	31.2	5000.0	9.000	On	N	19.8	24.8	56.0
12.277500	47.7	5000.0	9.000	On	N	19.8	12.3	60.0

Frequency	Average	Meas. Time	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)			(dB)	(dB)	(dBµV)
0.199500	35.0	5000.0	9.000	On	N	19.9	18.6	53.6
0.487500	33.6	5000.0	9.000	On	L1	19.9	12.6	46.2
0.555000	34.2	5000.0	9.000	On	N	19.9	11.8	46.0
0.627000	33.8	5000.0	9.000	On	N	19.8	12.2	46.0
0.762000	31.3	5000.0	9.000	On	L1	19.8	14.7	46.0
12.286500	34.8	5000.0	9.000	On	L1	19.8	15.2	50.0





ANNEX B: Persons involved in this testing

Test Item	Tester
Radiated Emission	Li Zongliang
Conducted Emission	Guo Qian

END OF REPORT